


<b>Search Notes</b>  	<b>Application/Control No.</b>  10580392	<b>Applicant(s)/Patent Under Reexamination</b>  WANNOWIUS ET AL.
	<b>Examiner</b>  LUKE E KARPINSKI	<b>Art Unit</b>  1616

SEARCHED			
Class	Subclass	Date	Examiner
none			

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (all db's) see atached search history report	6/30/2008, 7/14/2008, 7/15/2008	Luke Karpinski
EAST and PALM inventor name search	7/15/2008	Luke Karpinski
STIC structure, method, and inventor name search	7/09/2008	Luke Karpinski

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner